

**Search Notes****Application/Control No.**

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**Examiner**

Y. Lee

**Applicant(s)/Patent under Reexamination**

ISHIZUKA ET AL.

**Art Unit**

2621

**SEARCHED**

Class	Subclass	Date	Examiner
375	240.01 240.12 240.28 **	3/14/2007	YL
H04N	7/12		
update	search	8/29/2007	YL
update	search	3/13/2008	YL
375	240.25		
update	search	10/28/2008	YL

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner